

# PCA9306 デュアル双方向 I<sup>2</sup>C バスおよび SMBus 電圧レベル・トランスレータ

## 1 特長

- 混在モードの I<sup>2</sup>C アプリケーションで、SDA および SCL ライン用の 2 ビット双方向トランスレータ
- I<sup>2</sup>C バスおよび SMBus 互換
- 最大伝播遅延が 1.5ns 未満で、Standard-mode および Fast-mode の I<sup>2</sup>C デバイスと複数のコントローラに対応
- 次の電圧レベル変換が可能
  - 1.2V の V<sub>REF1</sub> と、1.8V、2.5V、3.3V、5V の V<sub>REF2</sub>
  - 1.8V の V<sub>REF1</sub> と、2.5V、3.3V、5V の V<sub>REF2</sub>
  - 2.5V の V<sub>REF1</sub> と、3.3V または 5V の V<sub>REF2</sub>
  - 3.3V の V<sub>REF1</sub> と、5V の V<sub>REF2</sub>
- 方向ピンを必要としない双方向電圧レベル変換
- 入力および出力ポート間のオン抵抗が 3.5Ω と低いことにより信号の歪みを低減
- オープン・ドレインの I<sup>2</sup>C I/O ポート (SCL1、SDA1、SCL2、SDA2)
- 5V 許容の I<sup>2</sup>C I/O ポートにより、混在モード信号動作をサポート
- EN = LOW のとき SCL1、SDA1、SCL2、SDA2 ピンが高インピーダンス
- EN = LOW のとき、絶縁のためのロックアップ・フリー動作
- フロースルー・ピン配置によりプリント基板の配線を簡素化
- JESD 78、Class II 準拠で 100mA 超のラッチアップ性能
- JESD 22 を上回る ESD 保護
  - 2000V、人体モデル (A114-A)
  - 1000V、デバイス帯電モデル (C101)

## 2 アプリケーション

- I<sup>2</sup>C、SMBus、PMBus、MDIO、UART、低速 SDIO、GPIO、その他の 2 信号インターフェイス
- サーバー
- ルーター (テレコム・スイッチング機器)
- パーソナル・コンピュータ
- 産業用オートメーション

## 3 概要

PCA9306 デバイスは、イネーブル (EN) 入力付きデュアル双方向 I<sup>2</sup>C および SMBus 電圧レベル・トランスレータであり、1.2V~3.3V の V<sub>REF1</sub> と、1.8V~5.5V の V<sub>REF2</sub> で動作します。

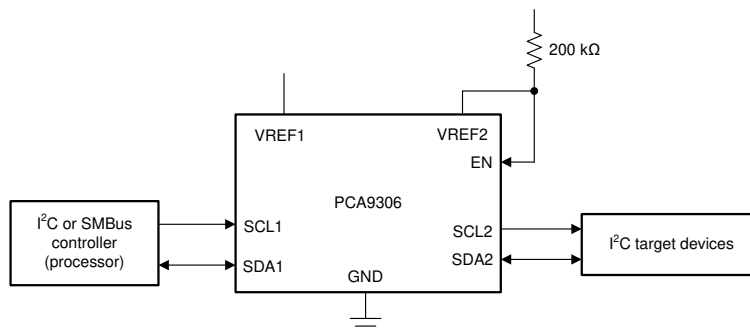
PCA9306 デバイスは、方向ピンを使用せず、1.2V と 5V の電圧を双方向に変換できます。スイッチのオン抵抗 (R<sub>ON</sub>) が低いため、最小の伝播遅延で接続が可能です。EN を HIGH にすると、トランスレータ・スイッチがオンになり、SCL1 および SDA1 I/O がそれぞれ SCL2 および SDA2 I/O に接続され、ポート間の双方向データ・フローが可能になります。EN が LOW のとき、トランスレータ・スイッチはオフになり、ポート間は高インピーダンス状態になります。

電圧変換に加えて、PCA9306 は、EN ピンを制御して Fast mode 通信中に低速なバスを切断することにより、400kHz バスを 100kHz バスから分離できます。

### パッケージ情報

部品番号	パッケージ <sup>(1)</sup>	パッケージ・サイズ <sup>(2)</sup>
PCA9306	SSOP (8)	2.95mm × 4mm
	VSSOP (8)	2.3mm × 3.1mm
	X2SON (8)	1.4mm × 1mm
	DSBGA (8)	1.98mm × 0.98mm

- (1) 利用可能なすべてのパッケージについては、このデータシートの末尾にある注文情報を参照してください。
- (2) パッケージ・サイズ (長さ×幅) は公称値であり、該当する場合はピンも含まれます。



アプリケーション概略図



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## 4 Revision History

資料番号末尾の英字は改訂を表しています。その改訂履歴は英語版に準じています。

<b>Changes from Revision N (October 2021) to Revision O (September 2023)</b> .....	<b>Page</b>
• 「デバイス情報」表を「パッケージ情報」表に変更 .....	1
• Changed the <i>Thermal Information</i> table values for the DQE package.....	6
<b>Changes from Revision M (April 2019) to Revision N (October 2021)</b> .....	<b>Page</b>
• I2C に言及している場合、文書全体にわたって旧式の用語をコントローラおよびターゲットに変更.....	1
• Changed the <i>Thermal Information</i> table values for the DCT and DCU packages.....	6
• Changed the MIN and MAX values of $V_{IK}$ in the <i>Electrical Characteristics</i> table.....	6
• Changed $t_{PHL}$ to show the package values in the <i>Switching Characteristics AC Performance (Translating Down) (EN = 3.3 V)</i> table.....	7
• Changed $t_{PHL}$ to show the package values in the <i>Switching Characteristics AC Performance (Translating Down) (EN = 2.5 V)</i> table.....	7
• Changed $t_{PHL}$ to show the package values in the <i>Switching Characteristics AC Performance (Translating Up) (EN = 3.3 V)</i> table.....	7
• Changed $t_{PHL}$ to show the package values in the <i>Switching Characteristics AC Performance (Translating Up) (EN = 2.5 V)</i> table.....	7
<b>Changes from Revision L (April 2016) to Revision M (April 2019)</b> .....	<b>Page</b>
• Changed the DQE package family From: VSSON to X2SON.....	4
• Added new section to <i>Overview</i> .....	10
• Changed the labels in <a href="#">図 9-4</a> . The red curve is > 2 V, the black curve is ≤ 2 V. ....	20
<b>Changes from Revision K (October 2014) to Revision L (April 2016)</b> .....	<b>Page</b>
• 「オン接続」を「オン抵抗」に変更.....	1
• マシン・モデルの ESD 定格を削除.....	1
• 「概要」セクションの最後の文で「100kHz」の後に「バス」を追加 .....	1
• 「製品情報」表の本体サイズの寸法を変更 .....	1

• Replaced pinout diagrams.....	4
• Added I/O column to the <i>Pin Functions</i> table .....	4
• Deleted RVH package from <i>Pin Configuration and Functions</i> section .....	4
• Moved T <sub>stg</sub> from <i>Handling Ratings</i> to <i>Absolute Maximum Ratings</i> .....	5
• Added a note following the <i>Electrical Characteristics</i> table.....	6
• Added <a href="#">☒ 7-1</a> to the <i>Parameter Measurement Information</i> section.....	9
• Changed <a href="#">☒ 7-2</a> .....	9
• Changed "repeater" to "level shifter" in second paragraph of the <i>Overview</i> section .....	10
• Deleted the last row of the <a href="#">Design Requirements</a> table. ....	18
• Corrected equation from $f_{knee} = 0.5 / RT$ (10%–80%) to $f_{knee} = 0.5 / RT$ (10%–90%).....	19

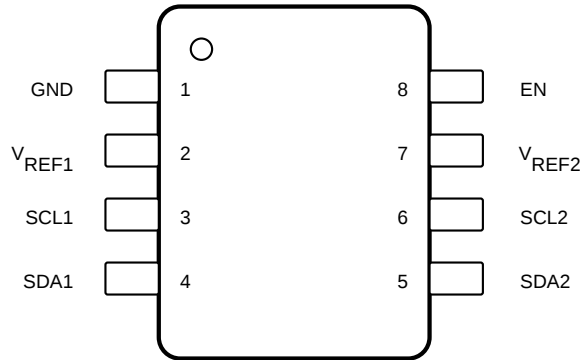
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<b>Changes from Revision J (October 2010) to Revision K (December 2012)</b>	<b>Page</b>
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• 「ピン構成および機能」セクション、「取り扱いに関する定格」表、「機能説明」セクション、「デバイスの機能モード」セクション、「アプリケーションと実装」セクション、「電源に関する推奨事項」セクション、「レイアウト」セクション、「デバイスおよびドキュメントのサポート」セクション、「メカニカル、パッケージ、および注文情報」セクションを追加.....	1
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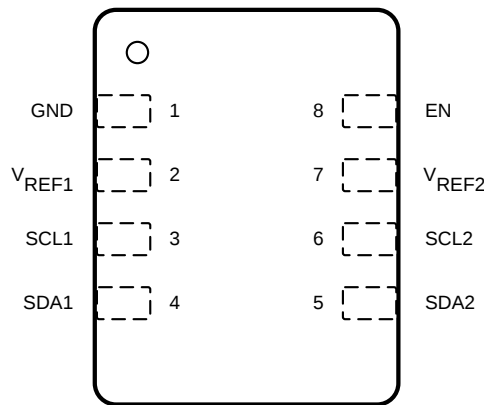
## 5 Pin Configuration and Functions



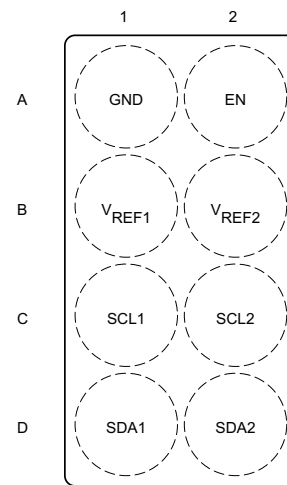
5-1. DCT Package 8-Pin SSOP (Top View)



5-2. DCU Package 8-Pin VSSOP (Top View)



5-3. DQE Package 8-Pin X2SON (Top View)



5-4. YZT Package 8-Pin DSBGA (Top View)

表 5-1. Pin Functions

NAME	PIN NO.		I/O	DESCRIPTION
	NO.			
	DCT, DCU, DQE	YZT		
EN	8	A2	I	Switch enable input
GND	1	A1	—	Ground, 0 V
SCL1	3	C1	I/O	Serial clock, low-voltage side
SCL2	6	C2	I/O	Serial clock, high-voltage side
SDA1	4	D1	I/O	Serial data, low-voltage side
SDA2	5	D2	I/O	Serial data, high-voltage side
V <sub>REF1</sub>	2	B1	I	Low-voltage-side reference supply voltage for SCL1 and SDA1
V <sub>REF2</sub>	7	B2	I	High-voltage-side reference supply voltage for SCL2 and SDA2

## 6 Specifications

### 6.1 Absolute Maximum Ratings

over operating ambient temperature range (unless otherwise noted) see <sup>(1)</sup>

		MIN	MAX	UNIT
V <sub>REF1</sub>	DC reference voltage range	-0.5	7	V
V <sub>REF2</sub>	DC reference bias voltage range	-0.5	7	V
V <sub>I</sub>	Input voltage range <sup>(2)</sup>	-0.5	7	V
V <sub>I/O</sub>	Input/output voltage range <sup>(2)</sup>	-0.5	7	V
	Continuous channel current		128	mA
I <sub>IK</sub>	Input clamp current	V <sub>I</sub> < 0	-50	mA
T <sub>J(max)</sub>	Maximum junction temperature		125	°C
T <sub>stg</sub>	Storage temperature range	-65	150	°C

- (1) Operation outside the *Absolute Maximum Ratings* may cause permanent device damage. Absolute maximum ratings do not imply functional operation of the device at these or any other conditions beyond those listed under *Recommended Operating Conditions*. If briefly operating outside the *Recommended Operating Conditions* but within the *Absolute Maximum Ratings*, the device may not sustain damage, but it may not be fully functional. Operating the device in this manner may affect device reliability, functionality, performance, and shorten the device lifetime.
- (2) The input and input/output negative voltage ratings may be exceeded if the input and output current ratings are observed.

### 6.2 ESD Ratings

			VALUE	UNIT
V <sub>(ESD)</sub>	Electrostatic discharge	Human body model (HBM), per ANSI/ESDA/JEDEC JS-001, all pins <sup>(1)</sup>	±2000	V
		Charged device model (CDM), per ANSI/ESDA/JEDEC JS-0011, all pins <sup>(2)</sup>	±1000	

- (1) JEDEC document JEP155 states that 500-V HBM allows safe manufacturing with a standard ESD control process.
- (2) JEDEC document JEP157 states that 250-V CDM allows safe manufacturing with a standard ESD control process.

### 6.3 Recommended Operating Conditions

			MIN	MAX	UNIT
V <sub>I/O</sub>	Input/output voltage	SCL1, SDA1, SCL2, SDA2	0	5.5	V
V <sub>REF1</sub> <sup>(1)</sup>	Reference voltage		0	5.5	V
V <sub>REF2</sub> <sup>(1)</sup>	Reference voltage		0	5.5	V
EN	Enable input voltage		0	5.5	V
I <sub>PASS</sub>	Pass switch current			64	mA
T <sub>A</sub>	Operating ambient temperature		-40	85	°C

- (1) To support translation, V<sub>REF1</sub> supports 1.2 V to V<sub>REF2</sub> - 0.6 V. V<sub>REF2</sub> must be between V<sub>REF1</sub> + 0.6 V to 5.5 V. See [セクション 9.2](#) for more information.

## 6.4 Thermal Information

THERMAL METRIC <sup>(1)</sup>		PCA9306				UNIT
		DCT	DCU	DQE	YZT	
		8 PINS	8 PINS	8 PINS	8 PINS	
$R_{\theta JA}$	Junction-to-ambient thermal resistance	254.1	275.5	299.3	125.5	°C/W
$R_{\theta JC(top)}$	Junction-to-case (top) thermal resistance	148.6	127.1	166.9	1	°C/W
$R_{\theta JB}$	Junction-to-board thermal resistance	168.8	186.9	188.30	62.7	°C/W
$\Psi_{JT}$	Junction-to-top characterization parameter	70.1	65.7	18.0	3.4	°C/W
$\Psi_{JB}$	Junction-to-board characterization parameter	167.4	185.9	187.4	62.7	°C/W

(1) For more information about traditional and new thermal metrics, see the [Semiconductor and IC Package Thermal Metrics](#) application report.

## 6.5 Electrical Characteristics

over recommended operating ambient temperature range (unless otherwise noted)

PARAMETER		TEST CONDITIONS		MIN	TYP <sup>(1)</sup>	MAX	UNIT		
$V_{IK}$	Input clamp voltage	$I_I = -18 \text{ mA}$ ,	$EN = 0 \text{ V}$	-1.2		0	V		
$I_{IH}$	Input leakage current	$V_I = 5 \text{ V}$ ,	$EN = 0 \text{ V}$			5	$\mu\text{A}$		
$C_i(EN)$	Input capacitance	$V_I = 3 \text{ V}$ or 0			11		pF		
$C_{io(off)}$	Off capacitance	SCLn, SDAn	$V_O = 3 \text{ V}$ or 0,	$EN = 0 \text{ V}$	4	6	pF		
$C_{io(on)}$	On capacitance	SCLn, SDAn	$V_O = 3 \text{ V}$ or 0,	$EN = 3 \text{ V}$	10.5	12.5	pF		
$R_{ON}$ <sup>(2)</sup>	On-state resistance	SCLn, SDAn	$V_I = 0$	$I_O = 64 \text{ mA}$	$EN = 4.5 \text{ V}$	3.5	5.5	$\Omega$	
					$EN = 3 \text{ V}$	4.7	7		
					$EN = 2.3 \text{ V}$	6.3	9.5		
			$V_I = 0$	$I_O = 15 \text{ mA}$	$EN = 1.5 \text{ V}$	25.5	32		
					$EN = 4.5 \text{ V}$	1	6		15
					$EN = 3 \text{ V}$	20	60		140
$V_I = 1.7 \text{ V}$ <sup>(3)</sup>	$I_O = 15 \text{ mA}$	$EN = 2.3 \text{ V}$	20	60	140				

(1) All typical values are at  $T_A = 25^\circ\text{C}$ .

(2) Measured by the voltage drop between the SCL1 and SCL2, or SDA1 and SDA2 terminals, at the indicated current through the switch. Minimum ON-state resistance is determined by the lowest voltage of the two terminals.

(3) Measured in current sink configuration only (See [Figure 7-1](#))

### 6.6 Switching Characteristics AC Performance (Translating Down) (EN = 3.3 V)

over recommended operating ambient temperature range, EN = 3.3 V,  $V_{IH} = 3.3$  V,  $V_{IL} = 0$ ,  $V_M = 1.15$  V (unless otherwise noted) (see [7-1](#)).

PARAMETER <sup>(1)</sup>	FROM (INPUT)	TO (OUTPUT)	Package	C <sub>L</sub> = 50 pF		C <sub>L</sub> = 30 pF		C <sub>L</sub> = 15 pF		UNIT
				MIN	MAX	MIN	MAX	MIN	MAX	
t <sub>PLH</sub>	SCL2 or SDA2	SCL1 or SDA1		0	0.8	0	0.6	0	0.3	ns
t <sub>PHL</sub>			YZT, DQE	0	1.2	0	1	0	0.5	
			DCU, DCT					0	0.75	

(1) Translating down: the high-voltage side driving toward the low-voltage side

### 6.7 Switching Characteristics AC Performance (Translating Down) (EN = 2.5 V)

over recommended operating ambient temperature range, EN = 2.5 V,  $V_{IH} = 3.3$  V,  $V_{IL} = 0$ ,  $V_M = 0.75$  V (unless otherwise noted) (see [7-1](#)).

PARAMETER <sup>(1)</sup>	FROM (INPUT)	TO (OUTPUT)	Package	C <sub>L</sub> = 50 pF		C <sub>L</sub> = 30 pF		C <sub>L</sub> = 15 pF		UNIT
				MIN	MAX	MIN	MAX	MIN	MAX	
t <sub>PLH</sub>	SCL2 or SDA2	SCL1 or SDA1		0	1	0	0.7	0	0.4	ns
t <sub>PHL</sub>			YZT, DQE	0	1.3	0	1	0	0.6	
			DCT, DCU					0	0.75	

(1) Translating down: the high-voltage side driving toward the low-voltage side

### 6.8 Switching Characteristics AC Performance (Translating Up) (EN = 3.3 V)

over recommended operating ambient temperature range, EN = 3.3 V,  $V_{IH} = 2.3$  V,  $V_{IL} = 0$ ,  $V_T = 3.3$  V,  $V_M = 1.15$  V,  $R_L = 300$  Ω (unless otherwise noted) (see [7-1](#)).

PARAMETER <sup>(1)</sup>	FROM (INPUT)	TO (OUTPUT)	Packages	C <sub>L</sub> = 50 pF		C <sub>L</sub> = 30 pF		C <sub>L</sub> = 15 pF		UNIT
				MIN	MAX	MIN	MAX	MIN	MAX	
t <sub>PLH</sub>	SCL1 or SDA1	SCL2 or SDA2		0	0.9	0	0.6	0	0.4	ns
t <sub>PHL</sub>			YZT, DQE	0	1.4	0	1.1	0	0.7	
			DCU, DCT					0	1.0	

(1) Translating up: the low-voltage side driving toward the high-voltage side

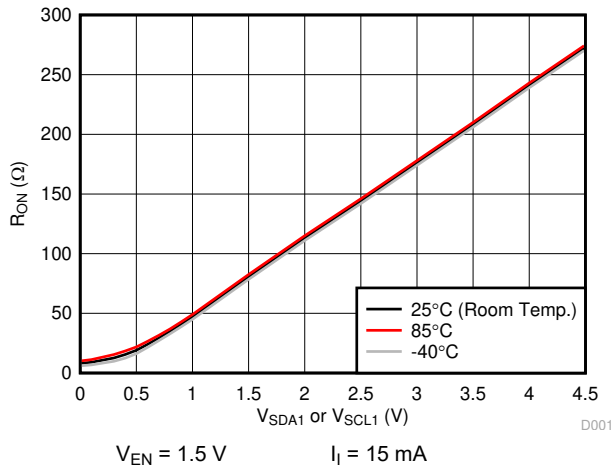
### 6.9 Switching Characteristics AC Performance (Translating Up) (EN = 2.5 V)

over recommended operating ambient temperature range, EN = 2.5 V,  $V_{IH} = 2.3$  V,  $V_{IL} = 0$ ,  $V_T = 3.3$  V,  $V_M = 0.75$  V,  $R_L = 300$  Ω (unless otherwise noted) (see [7-1](#)).

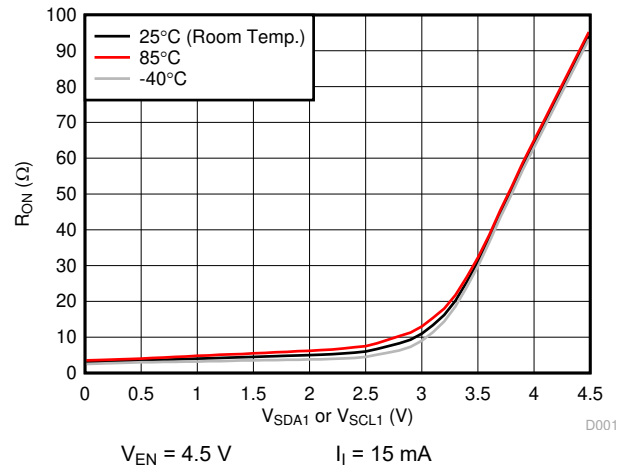
PARAMETER <sup>(1)</sup>	FROM (INPUT)	TO (OUTPUT)	Packages	C <sub>L</sub> = 50 pF		C <sub>L</sub> = 30 pF		C <sub>L</sub> = 15 pF		UNIT
				MIN	MAX	MIN	MAX	MIN	MAX	
t <sub>PLH</sub>	SCL1 or SDA1	SCL2 or SDA2		0	1	0	0.6	0	0.4	ns
t <sub>PHL</sub>			YZT, DQE	0	1.3	0	1.3	0	0.8	
			DCT, DCU					0	1.3	

(1) Translating up: the low-voltage side driving toward the high-voltage side

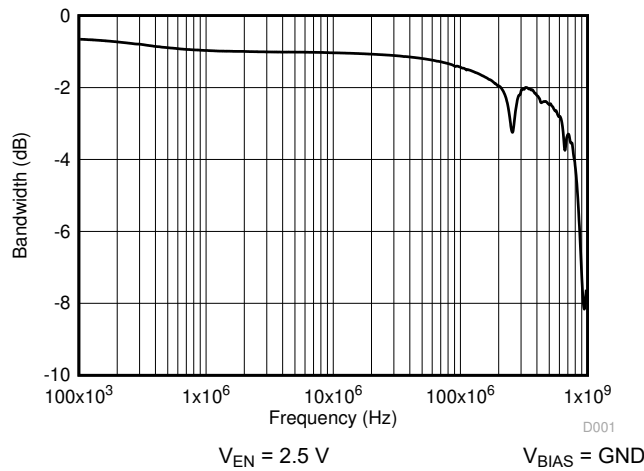
### 6.10 Typical Characteristics



6-1. On-Resistance ( $R_{ON}$ ) vs Input Voltage ( $V_{SDA1}$  or  $V_{SCL1}$ )



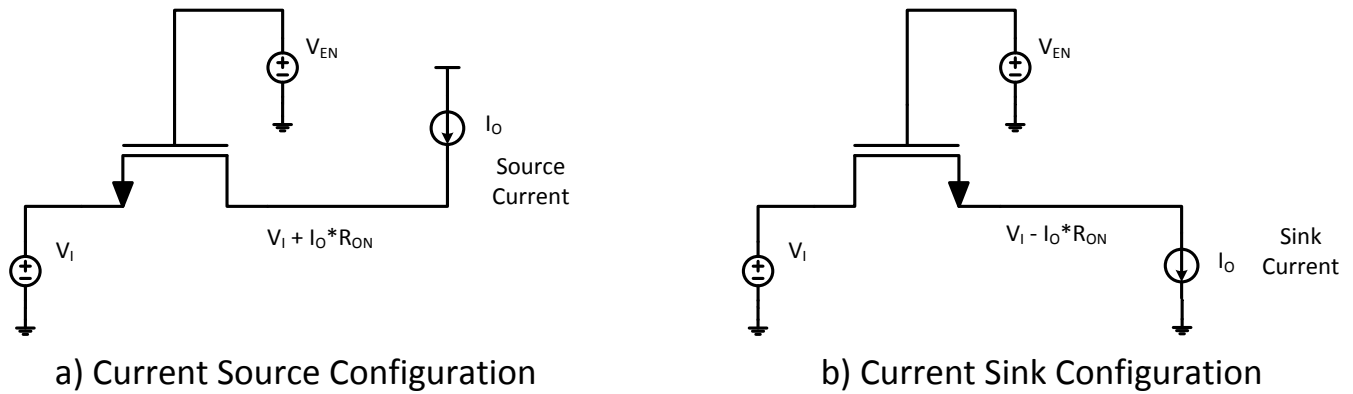
6-2. On-Resistance ( $R_{ON}$ ) vs Input Voltage ( $V_{SDA1}$  or  $V_{SCL1}$ )



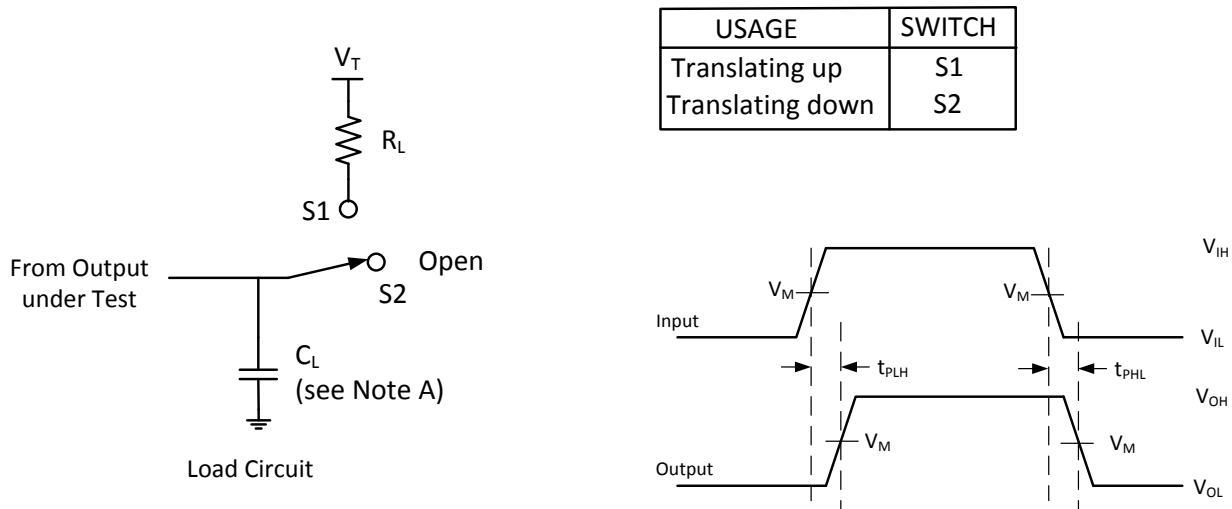
6-3. Typical Bandwidth of PCA9306



## 7 Parameter Measurement Information



7-1. Current Source and Current Sink Configurations for  $R_{ON}$  Measurements



- NOTES: A.  $C_L$  includes probe and jig capacitance  
 B. All input pulses are supplied by generators having the following characteristics:  $PRR \leq 10$  MHz,  $Z_0 = 50 \Omega$ ,  $t_r \leq 2$  ns,  $t_f \leq 2$  ns.  
 C. The outputs are measured one at a time, with one transition per measurement.

7-2. Load Circuit for Outputs

## 8 Detailed Description

### 8.1 Overview

The PCA9306 device is a dual bidirectional I<sup>2</sup>C and SMBus voltage-level translator with an enable (EN) input and operates without use of a direction pin. The voltage supply range for V<sub>REF1</sub> is 1.2 V to 3.3 V and the supply range for V<sub>REF2</sub> is 1.8 V to 5.5 V.

The PCA9306 device can also be used to run two buses, one at 400-kHz operating frequency and the other at 100-kHz operating frequency. If the two buses are operating at different frequencies, the 100-kHz bus must be disconnected by using the EN pin when the 400-kHz operation of the main bus is required. If the controller is running at 400 kHz, the maximum system operating frequency may be less than 400 kHz because of the delays added by the level shifter.

In I<sup>2</sup>C applications, the bus capacitance limit of 400 pF restricts the number of devices and bus length. The capacitive load on both sides of the PCA9306 device must be taken into account when approximating the total load of the system, ensuring the sum of both sides is under 400 pF.

Both the SDA and SCL channels of the PCA9306 device have the same electrical characteristics, and there is minimal deviation from one output to another in voltage or propagation delay. This is a benefit over discrete-transistor voltage-translation solutions, because the fabrication of the switch is symmetrical. The translator provides excellent ESD protection to lower-voltage devices and at the same time protects less-ESD-resistant devices.

#### 8.1.1 Definition of threshold voltage

This document references a threshold voltage denoted as V<sub>th</sub>, which appears multiple times throughout this document when discussing the NFET between V<sub>REF1</sub> and V<sub>REF2</sub>. The value of V<sub>th</sub> is approximately 0.6 V at room temperature.

#### 8.1.2 Correct Device Set Up

In a normal set up shown in [Figure 8-1](#), the enable pin and V<sub>REF2</sub> are shorted together and tied to a 200-kΩ resistor, and a reference voltage equal to V<sub>REF1</sub> plus the FET threshold voltage is established. This reference voltage is used to help pass lows from one side to another more effectively while still separating the different pull up voltages on both sides.

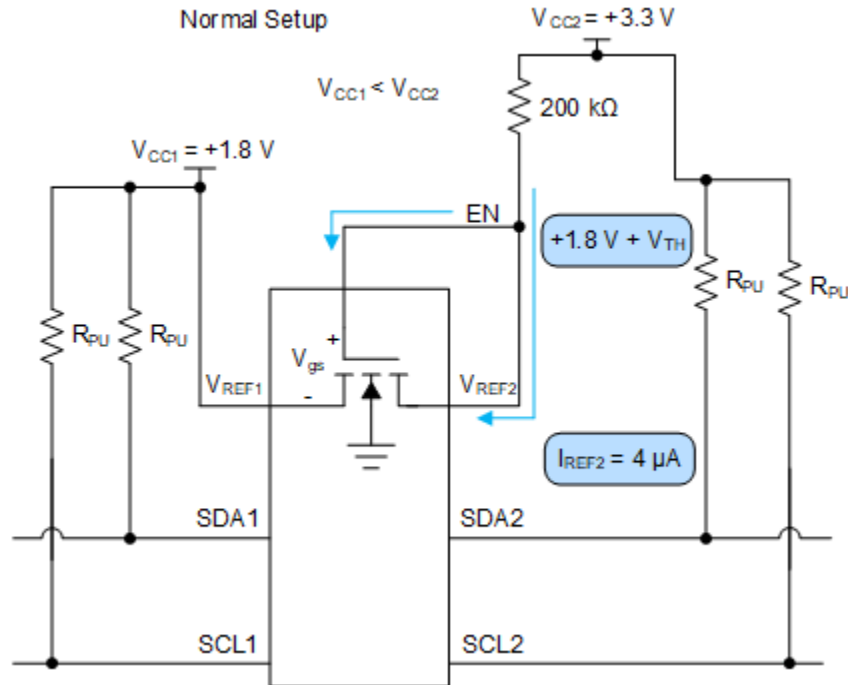


图 8-1. Normal Setup

Care should be taken to make sure  $V_{REF2}$  has an external resistor tied between it and  $V_{CC2}$ . If  $V_{REF2}$  is tied directly to the  $V_{CC2}$  rail without a resistor, then there is no external resistance from the  $V_{CC2}$  to  $V_{CC1}$  to limit the current such as in 图 8-2. This effectively looks like a low impedance path for current to travel through and potentially break the pass FET if the current flowing through the pass FET is larger than the absolute maximum continuous channel current specified in section 6.1. The continuous channel current is larger with a higher voltage difference between  $V_{CC1}$  and  $V_{CC2}$ .

图 8-2 shows an improper set up. If  $V_{CC2}$  is larger than  $V_{CC1}$  but less than  $V_{th}$ , the impedance between  $V_{CC1}$  and  $V_{CC2}$  is high resulting in a low drain to source current, which does not cause damage to the device. Concern arises when  $V_{CC2}$  becomes larger than  $V_{CC1}$  by  $V_{th}$ . During this event, the NFET turns on and begin to conduct current. This current is dependent on the gate to source voltage and drain to source voltage.

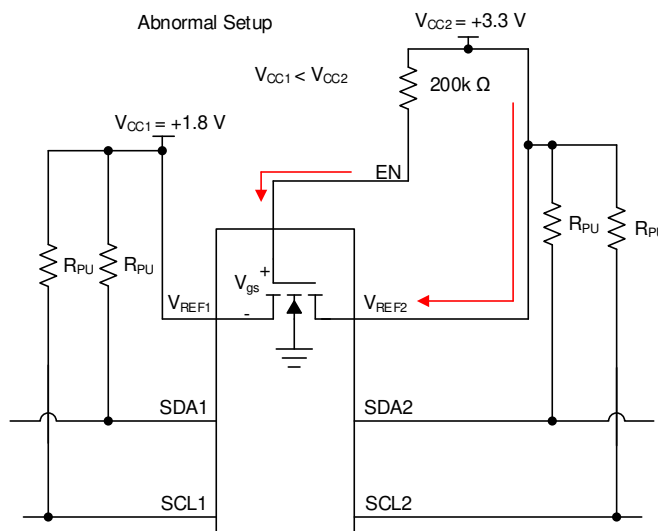
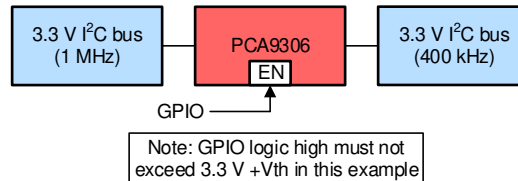


图 8-2. Abnormal Setup

### 8.1.3 Disconnecting an I2C target from the Main I2C Bus Using the EN Pin

PCA9306 can be used as a switch to disconnect one side of the device from the main I2C bus. This can be advantageous in multiple situations. One instance of this situation is if there are devices on the I2C bus which only supports fast mode (400 kHz) while other devices on the bus support fast mode plus (1 MHz). An example of this is displayed in [Figure 8-3](#).

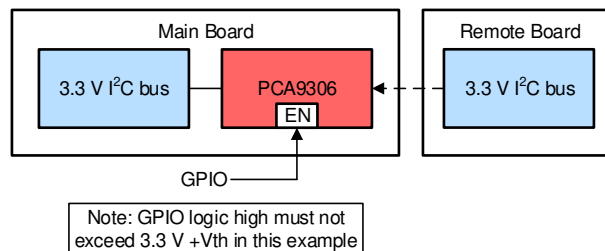


**Figure 8-3. Example of an I2C bus with multiple supported frequencies**

In this situation, if the controller is on the 1 MHz side then communicating at 1 MHz should not be attempted if PCA9306 were enabled. It needs to be disabled for PCA9306 to avoid possibly glitching state machines in devices which were designed to operate correctly at 400 kHz or slower. When PCA9306 is disabled, the controller can communicate with the 1 MHz devices without disturbing the 400 kHz bus. When the PCA9306 is enabled, communication across both sides at 400 kHz is acceptable.

### 8.1.4 Supporting Remote Board Insertion to Backplane with PCA9306

Another situation where PCA9306 is advantageous when using its enable feature is when a remote board with I2C lines needs to be attached to a main board (backplane) with an I2C bus such as in [Figure 8-4](#). If connecting a remote board to a backplane is not done properly, the connection could result in data corruption during a transaction or the insertion could generate an unintended pulse on the SCL line. Which could glitch an I2C device state machine causing the I2C bus to get stuck.

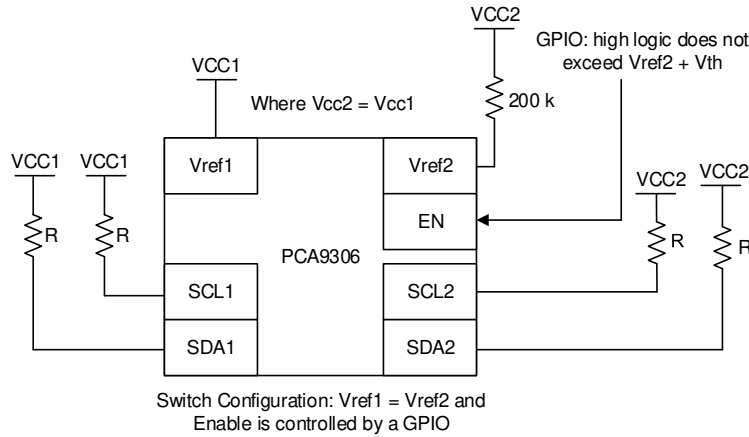


**Figure 8-4. An example of connecting a remote board to a main board (backplane)**

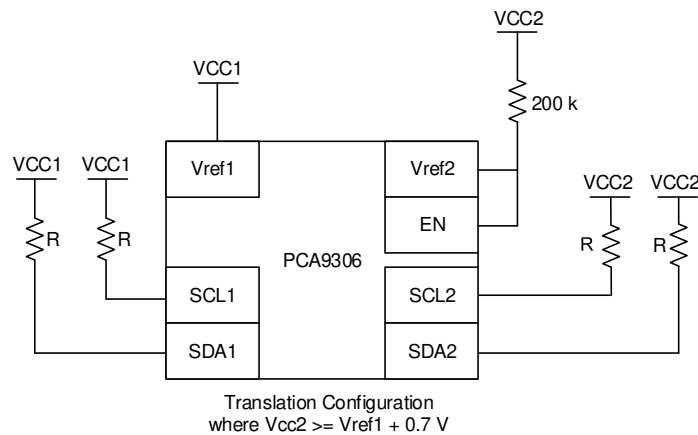
PCA9306 can be used to support this application because it can be disabled while making the connection. Then it is enabled once the remote board is powered on and the buses on both sides are IDLE.

### 8.1.5 Switch Configuration

PCA9306 has the capability of being used with its  $V_{REF1}$  voltage equal to  $V_{REF2}$ . This essentially turns the device from a translator to a device which can be used as a switch, and in some situations this can be useful. The switch configuration is shown in [Figure 8-5](#) and translation mode is shown in [Figure 8-6](#).



8-5. Switch Configuration



8-6. Translation Configuration

When PCA9306 is in the switch configuration ( $V_{REF1} = V_{REF2}$ ), the propagation delays are different compared to the translator configuration. Taking a look at the propagation delays, if the pull up resistance and capacitance on both sides of the bus are equal, then in switch mode the PCA9306 has the same propagation delay from side one to two and side two to one. The propagation delays become lower when  $V_{CC1}/V_{CC2}$  is larger. For example, the propagation delay at 1.8 V is longer than at 5 V in the switching configuration. When PCA9306 is in translation mode, side one propagate lows to side two faster than side two can propagate lows to side 1. This time difference becomes larger the larger the difference between  $V_{CC2}$  and  $V_{CC1}$  becomes.

### 8.1.6 Controller on Side 1 or Side 2 of Device

I2C and SMBus are bidirectional protocol meaning devices on the bus can both transmit and receive data. PCA9306 was designed to allow for signals to be able to be transmitted from either side, thus allowing for the controller to be able to placed on either side of the device. 8-7 shows the controller on side two as opposed to the diagram on page 1 of this data sheet.

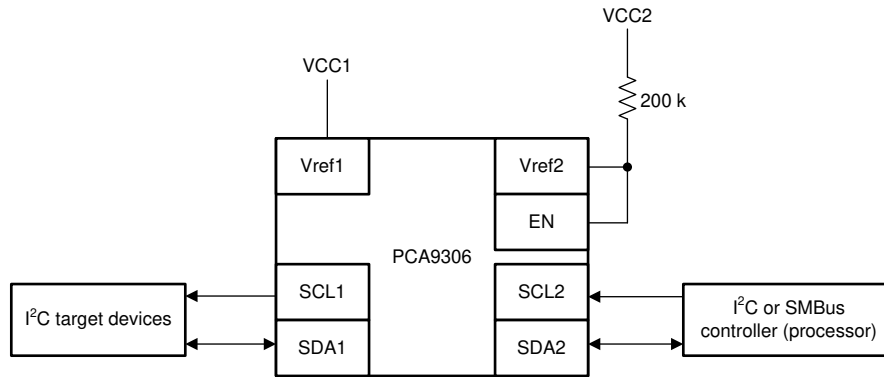


Figure 8-7. Controller on side 2 of PCA9306

### 8.1.7 LDO and PCA9306 Concerns

The  $V_{REF1}$  pin can be supplied by a low-dropout regulator (LDO), but in some cases the LDO may lose its regulation because of the bias current from  $V_{REF2}$  to  $V_{REF1}$ . If the LDO cannot sink the bias current, then the current has no other paths to ground and instead charges up the capacitance on the  $V_{REF1}$  node (both external and parasitic). This results in an increase in voltage on the  $V_{REF1}$  node. If no other paths for current to flow are established (such as back biasing of body diodes or clamping diodes through other devices on the  $V_{REF1}$  node), then the  $V_{REF1}$  voltage ends up stabilizing when  $V_{gs}$  of the pass FET is equal to  $V_{th}$ . This means  $V_{REF1}$  node voltage is  $V_{CC2} - V_{th}$ . Note that any targets/controllers running off of the LDO now see the  $V_{CC2} - V_{th}$  voltage which may cause damage to those targets/controllers if they are not rated to handle the increased voltage.

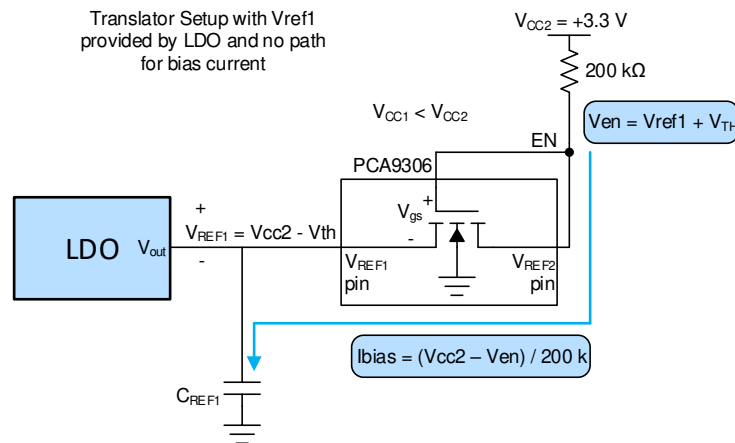


Figure 8-8. Example of no leakage current path when using LDO

To make sure the LDO does not lose regulation due to the bias current of PCA9306, a weak pull down resistor can be placed on  $V_{REF1}$  to ground to provide a path for the bias current to travel. The recommended pull down resistor is calculated by Equation 4 where 0.75 gives about 25% margin for error in case bias current increases during operation.

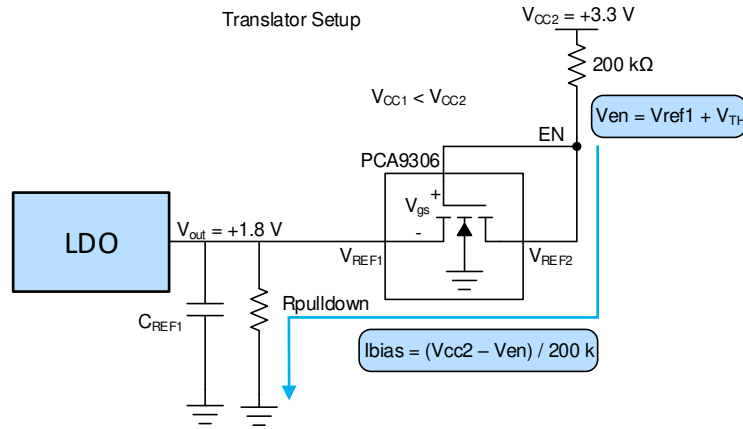


图 8-9. Example with Leakage current path when using an LDO

$$V_{en} = V_{REF1} + V_{th} \quad (1)$$

where

- $V_{th}$  is approximately 0.6 V

$$I_{bias} = (V_{CC2} - V_{en})/200k \quad (2)$$

$$R_{pulldown} = V_{OUT}/I_{bias} \quad (3)$$

$$\text{Recommended } R_{pulldown} = R_{pulldown} \times 0.75 \quad (4)$$

### 8.1.8 Current Limiting Resistance on $V_{REF2}$

The resistor is used to limit the current between  $V_{REF2}$  and  $V_{REF1}$  (denoted as  $R_{CC}$ ) and helps to establish the reference voltage on the enable pin. The 200k resistor can be changed to a lower value; however, the bias current proportionally increases as the resistor decreases.

$$I_{bias} = (V_{CC2} - V_{en})/R_{CC} : V_{en} = V_{REF1} + V_{th} \quad (5)$$

where

- $V_{th}$  is approximately 0.6V

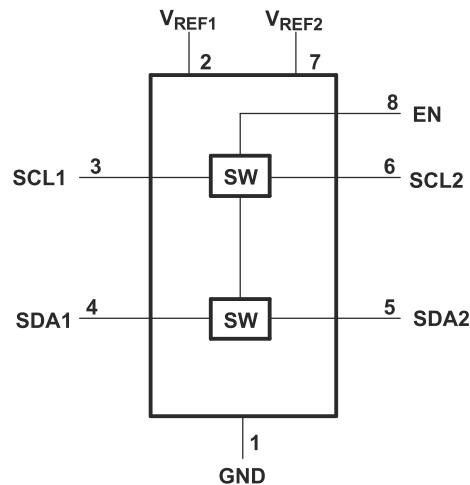
Keep in mind  $R_{CC}$  should not be sized low enough that  $I_{CC}$  exceeds the absolute maximum continuous channel current specified in section 6.1 which is described in 式 6.

$$R_{CC}(\min) \geq (V_{CC2} - V_{en})/0.128 : V_{en} = V_{REF1} + V_{th} \quad (6)$$

where

- $V_{th}$  is approximately 0.6V

## 8.2 Functional Block Diagram



8-10. Block Diagram of PCA9306

## 8.3 Feature Description

### 8.3.1 Enable (EN) Pin

The PCA9306 device is a double-pole, single-throw switch in which the gate of the transistors is controlled by the voltage on the EN pin. In [9-1](#), the PCA9306 device is always enabled when power is applied to  $V_{REF2}$ . In [9-2](#), the device is enabled when a control signal from a processor is in a logic-high state.

### 8.3.2 Voltage Translation

The primary feature of the PCA9306 device is translating voltage from an I<sup>2</sup>C bus referenced to  $V_{REF1}$  up to an I<sup>2</sup>C bus referenced to  $V_{DPU}$ , to which  $V_{REF2}$  is connected through a 200-k $\Omega$  pullup resistor. Translation on a standard, open-drain I<sup>2</sup>C bus is achieved by simply connecting pullup resistors from SCL1 and SDA1 to  $V_{REF1}$  and connecting pullup resistors from SCL2 and SDA2 to  $V_{DPU}$ . Information on sizing the pullup resistors can be found in the [Sizing Pullup Resistors](#) section.

## 8.4 Device Functional Modes

INPUT EN <sup>(1)</sup>	TRANSLATOR FUNCTION
H	Logic Lows are propagated from one side to the other, Logic Highs blocked (independent pull up resistors passively drive the line high)
L	Disconnect

(1) The SCL switch conducts if EN is  $\geq 0.6$  V higher than SCL1 or SCL2. The same is true of SDA.



## 9 Application and Implementation

### 注

以下のアプリケーション情報は、TI の製品仕様に含まれるものではなく、TI ではその正確性または完全性を保証いたしません。個々の目的に対する製品の適合性については、お客様の責任で判断していただくこととなります。お客様は自身の設計実装を検証しテストすることで、システムの機能を確認する必要があります。

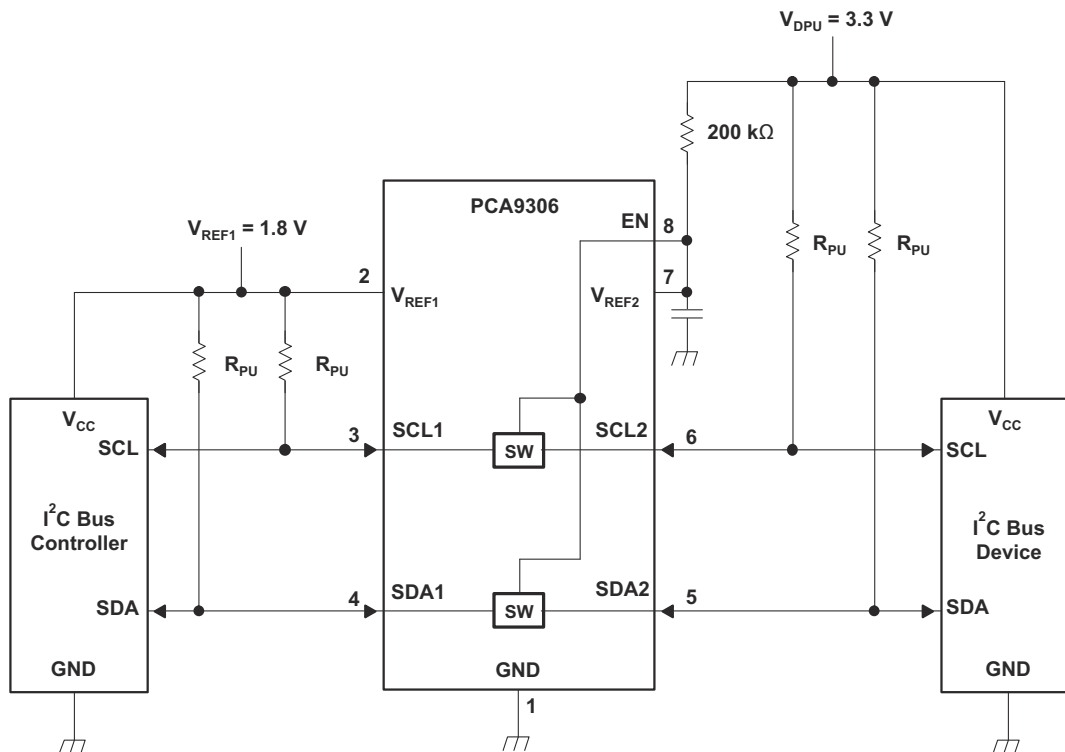
### 9.1 Application Information

#### 9.1.1 General Applications of I<sup>2</sup>C

As with the standard I<sup>2</sup>C system, pullup resistors are required to provide the logic-high levels on the translator bus. The size of these pullup resistors depends on the system, but each side of the repeater must have a pullup resistor. The device is designed to work with standard-mode and fast-mode I<sup>2</sup>C devices in addition to SMBus devices. Standard-mode I<sup>2</sup>C devices only specify 3 mA in a generic I<sup>2</sup>C system where standard-mode devices and multiple controllers are possible. Under certain conditions, high termination currents can be used. When the SDA1 or SDA2 port is low, the clamp is in the ON state, and a low-resistance connection exists between the SDA1 and SDA2 ports. Assuming the higher voltage is on the SDA2 port when the SDA2 port is high, the voltage on the SDA1 port is limited to the voltage set by  $V_{REF1}$ . When the SDA1 port is high, the SDA2 port is pulled to the pullup supply voltage of the drain ( $V_{DPU}$ ) by the pullup resistors. This functionality allows a seamless translation between higher and lower voltages selected by the user, without the need for directional control. The SCL1-SCL2 channel also functions in the same way as the SDA1-SDA2 channel.

#### 9.2 Typical Application

☒ 9-1 and ☒ 9-2 show how these pullup resistors are connected in a typical application, as well as two options for connecting the EN pin.



☒ 9-1. Typical Application Circuit (Switch Always Enabled)

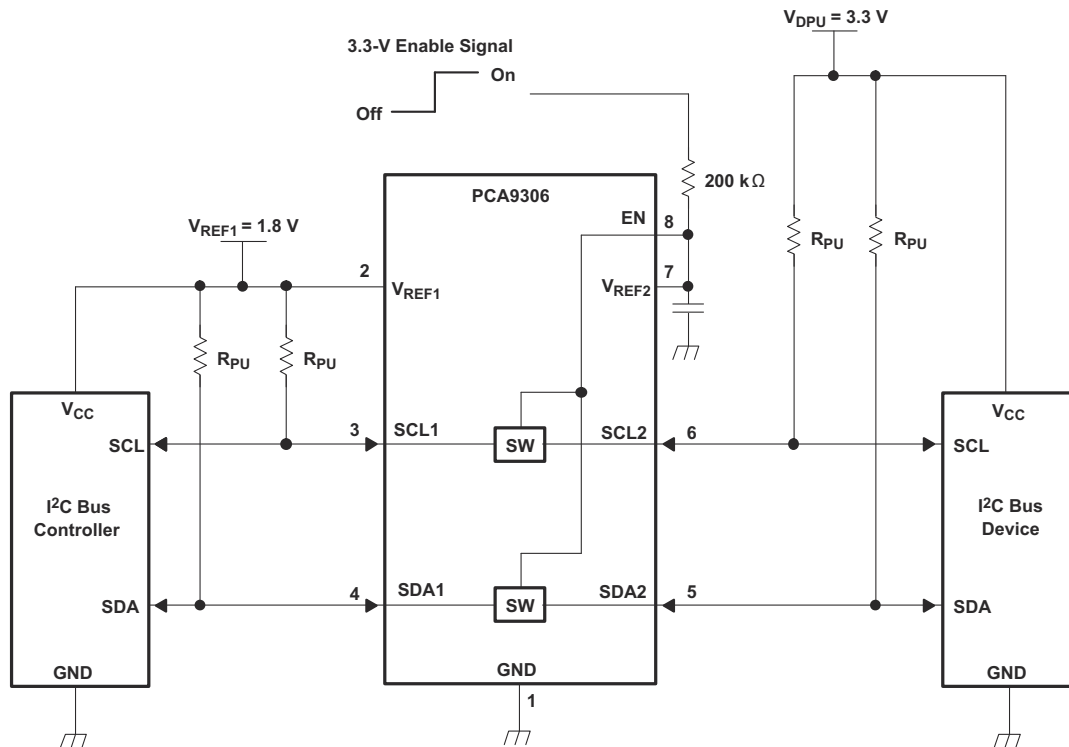


Figure 9-2. Typical Application Circuit (Switch Enable Control)

## 9.2.1 Design Requirements

		MIN	TYP <sup>(1)</sup>	MAX	UNIT
$V_{REF2}$	Reference voltage	$V_{REF1} + 0.6$	2.1	5	V
EN	Enable input voltage	$V_{REF1} + 0.6$	2.1	5	V
$V_{REF1}$	Reference voltage	1.2	1.5	4.4	V
$I_{PASS}$	Pass switch current		6		mA
$I_{REF}$	Reference-transistor current		5		$\mu$ A

(1) All typical values are at  $T_A = 25^\circ\text{C}$ .

## 9.2.2 Detailed Design Procedure

### 9.2.2.1 Bidirectional Voltage Translation

For the bidirectional clamping configuration (higher voltage to lower voltage or lower voltage to higher voltage), the EN input must be connected to  $V_{REF2}$  and both pins pulled to high-side  $V_{DPU}$  through a pullup resistor (typically 200 k $\Omega$ ). This allows  $V_{REF2}$  to regulate the EN input. A 100-pF filter capacitor connected to  $V_{REF2}$  is recommended. The I<sup>2</sup>C bus controller output can be push-pull or open-drain (pullup resistors may be required) and the I<sup>2</sup>C bus device output can be open-drain (pullup resistors are required to pull the SCL2 and SDA2 outputs to  $V_{DPU}$ ). However, if either output is push-pull, data must be unidirectional or the outputs must be 3-state capable and be controlled by some direction-control mechanism to prevent high-to-low contentions in either direction. If both outputs are open-drain, no direction control is needed.

### 9.2.2.2 Sizing Pullup Resistors

To get an estimate for the range of values that can be used for the pullup resistor, please refer to the application note [SLVA689](#). Figure 9-3 and Figure 9-4 respectively show the maximum and minimum pullup resistance allowable by the I<sup>2</sup>C specification for standard-mode (100 kHz) and fast-mode (400 kHz) operation.

### 9.2.2.3 PCA9306 Bandwidth

The maximum frequency of the PCA9306 device depends on the application. The device can operate at speeds of > 100 MHz given the correct conditions. The maximum frequency is dependent upon the loading of the application.

✉ 6-3 shows a bandwidth measurement of the PCA9306 device using a two-port network analyzer.

However, this is an analog type of measurement. For digital applications, the signal should not degrade up to the fifth harmonic of the digital signal. As a rule of thumb, the frequency bandwidth should be at least five times the maximum digital clock rate. This component of the signal is very important in determining the overall shape of the digital signal. In the case of the PCA9306 device, digital clock frequency of >100 MHz can be achieved.

The PCA9306 device does not provide any drive capability like the PCA9515 or PCA9517 series of devices. Therefore, higher-frequency applications require higher drive strength from the host side. No pullup resistor is needed on the host side (3.3 V) if the PCA9306 device is being driven by standard CMOS push-pull output driver. Ideally, it is best to minimize the trace length from the PCA9306 device on the sink side (1.8 V) to minimize signal degradation.

You can then use a simple formula to compute the maximum *practical* frequency component or the *knee* frequency ( $f_{knee}$ ). All fast edges have an infinite spectrum of frequency components. However, there is an inflection (or *knee*) in the frequency spectrum of fast edges where frequency components higher than  $f_{knee}$  are insignificant in determining the shape of the signal.

To calculate  $f_{knee}$ :

$$f_{knee} = 0.5 / RT \text{ (10\%–90\%)} \quad (7)$$

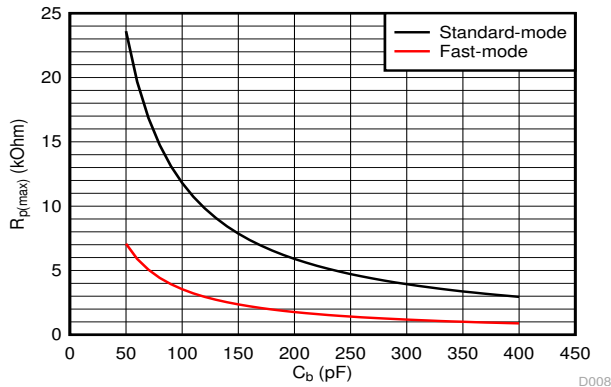
$$f_{knee} = 0.4 / RT \text{ (20\%–80\%)} \quad (8)$$

For signals with rise-time characteristics based on 10- to 90-percent thresholds,  $f_{knee}$  is equal to 0.5 divided by the rise time of the signal. For signals with rise-time characteristics based on 20- to 80-percent thresholds, which is very common in many current device specifications,  $f_{knee}$  is equal to 0.4 divided by the rise time of the signal.

Some guidelines to follow that help maximize the performance of the device:

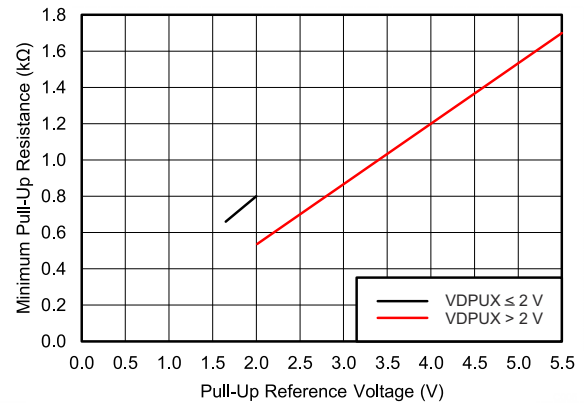
- Keep trace length to a minimum by placing the PCA9306 device close to the I<sup>2</sup>C output of the processor.
- The trace length should be less than half the time of flight to reduce ringing and line reflections or non-monotonic behavior in the switching region.
- To reduce overshoots, a pullup resistor can be added on the 1.8 V side; be aware that a slower fall time is to be expected.

### 9.2.3 Application Curve



Standard mode (f<sub>SCL</sub> = 100 kHz, t<sub>r</sub> = 1 μs)      Fast mode (f<sub>SCL</sub> = 400 kHz, t<sub>r</sub> = 300 ns)

**9-3. Maximum Pullup Resistance (R<sub>p(max)</sub>) vs Bus Capacitance (C<sub>b</sub>)**



V<sub>OL</sub> = 0.2 x V<sub>DPUX</sub>, I<sub>OL</sub> = 2 mA when V<sub>DPUX</sub> ≤ 2 V  
V<sub>OL</sub> = 0.4 V, I<sub>OL</sub> = 3 mA when V<sub>DPUX</sub> > 2 V

**9-4. Minimum Pullup Resistance (R<sub>p(min)</sub>) vs Pullup Reference Voltage (V<sub>DPUX</sub>)**

## 10 Power Supply Recommendations

For supplying power to the PCA9306 device, the  $V_{REF1}$  pin can be connected directly to a power supply. The  $V_{REF2}$  pin must be connected to the  $V_{DPU}$  power supply through a 200-k $\Omega$  resistor. Failure to have a high-impedance resistor between  $V_{REF2}$  and  $V_{DPU}$  results in excessive current draw and unreliable device operation. It is also worth noting, that in order to support voltage translation, the PCA9306 must have the EN and VREF2 pins shorted and then pulled up to  $V_{DPU}$  through a high-impedance resistor.

## 11 Layout

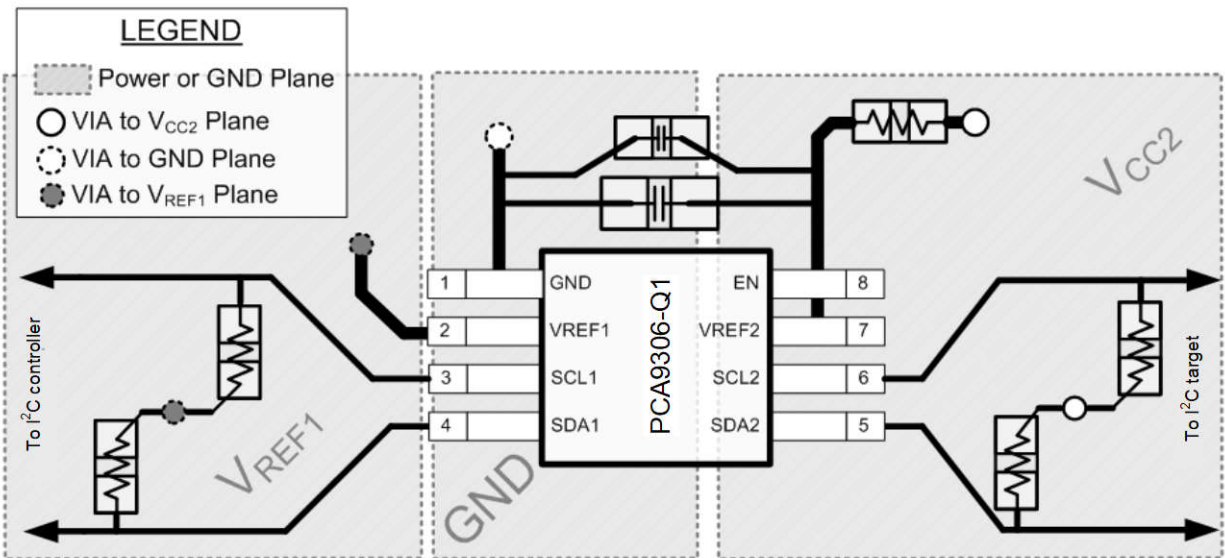
### 11.1 Layout Guidelines

For printed-circuit board (PCB) layout of the PCA9306 device, common PCB layout practices should be followed, but additional concerns related to high-speed data transfer such as matched impedances and differential pairs are not a concern for I<sup>2</sup>C signal speeds.

In all PCB layouts, it is a best practice to avoid right angles in signal traces, to fan out signal traces away from each other on leaving the vicinity of an integrated circuit (IC), and to use thicker trace widths to carry higher amounts of current that commonly pass through power and ground traces. The 100-pF filter capacitor should be placed as close to V<sub>REF2</sub> as possible. A larger decoupling capacitor can also be used, but a longer time constant of two capacitors and the 200-kΩ resistor results in longer turnon and turnoff times for the PCA9306 device. These best practices are shown in [Figure 11-1](#).

For the layout example provided in [Figure 11-1](#), it would be possible to fabricate a PCB with only two layers by using the top layer for signal routing and the bottom layer as a split plane for power (V<sub>CC</sub>) and ground (GND). However, a four-layer board is preferable for boards with higher-density signal routing. On a four-layer PCB, it is common to route signals on the top and bottom layer, dedicate one internal layer to a ground plane, and dedicate the other internal layer to a power plane. In a board layout using planes or split planes for power and ground, vias are placed directly next to the surface-mount component pad, which must attach to V<sub>CC</sub> or GND, and the via is connected electrically to the internal layer or the other side of the board. Vias are also used when a signal trace must be routed to the opposite side of the board, but this technique is not demonstrated in [Figure 11-1](#).

### 11.2 Layout Example



**Figure 11-1. PCA9306 Layout Example**

## 12 Device and Documentation Support

### 12.1 Receiving Notification of Documentation Updates

To receive notification of documentation updates, navigate to the device product folder on ti.com. In the upper right corner, click on *Alert me* to register and receive a weekly digest of any product information that has changed. For change details, review the revision history included in any revised document.

### 12.2 サポート・リソース

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ESD による破損は、わずかな性能低下からデバイスの完全な故障まで多岐にわたります。精密な IC の場合、パラメータがわずかに変化するだけで公表されている仕様から外れる可能性があるため、破損が発生しやすくなっています。

### 12.5 用語集

[テキサス・インスツルメンツ用語集](#) この用語集には、用語や略語の一覧および定義が記載されています。

## Mechanical, Packaging, and Orderable Information

The following pages include mechanical, packaging, and orderable information. This information is the most-current data available for the designated device. This data is subject to change without notice and without revision of this document. For browser-based versions of this data sheet, see the left-hand navigation pane.

**PACKAGING INFORMATION**

Orderable Device	Status (1)	Package Type	Package Drawing	Pins	Package Qty	Eco Plan (2)	Lead finish/ Ball material (6)	MSL Peak Temp (3)	Op Temp (°C)	Device Marking (4/5)	Samples
PCA9306DCTR	ACTIVE	SM8	DCT	8	3000	RoHS & Green	NIPDAU	Level-1-260C-UNLIM	-40 to 85	7BD (G, S, Y)	<a href="#">Samples</a>
PCA9306DCTT	ACTIVE	SM8	DCT	8	250	RoHS & Green	NIPDAU	Level-1-260C-UNLIM	-40 to 85	7BD (G, S, Y)	<a href="#">Samples</a>
PCA9306DCUR	ACTIVE	VSSOP	DCU	8	3000	RoHS & Green	NIPDAU   SN   NIPDAUAG	Level-1-260C-UNLIM	-40 to 85	(29O4, 7BDP, 7BDS, 7BDY)	<a href="#">Samples</a>
PCA9306DCUT	ACTIVE	VSSOP	DCU	8	250	RoHS & Green	NIPDAU   SN   NIPDAUAG	Level-1-260C-UNLIM	-40 to 85	(29O4, 7BDP, 7BDS, 7BDY)	<a href="#">Samples</a>
PCA9306DQER	ACTIVE	X2SON	DQE	8	5000	RoHS & Green	NIPDAU   NIPDAUAG	Level-1-260C-UNLIM	-40 to 85	(3M, 7F)	<a href="#">Samples</a>
PCA9306YZTR	ACTIVE	DSBGA	YZT	8	3000	RoHS & Green	SNAGCU	Level-1-260C-UNLIM	-40 to 85	7F	<a href="#">Samples</a>

(1) The marketing status values are defined as follows:

**ACTIVE:** Product device recommended for new designs.

**LIFEBUY:** TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

**NRND:** Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

**PREVIEW:** Device has been announced but is not in production. Samples may or may not be available.

**OBSOLETE:** TI has discontinued the production of the device.

(2) **RoHS:** TI defines "RoHS" to mean semiconductor products that are compliant with the current EU RoHS requirements for all 10 RoHS substances, including the requirement that RoHS substance do not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, "RoHS" products are suitable for use in specified lead-free processes. TI may reference these types of products as "Pb-Free".

**RoHS Exempt:** TI defines "RoHS Exempt" to mean products that contain lead but are compliant with EU RoHS pursuant to a specific EU RoHS exemption.

**Green:** TI defines "Green" to mean the content of Chlorine (Cl) and Bromine (Br) based flame retardants meet JS709B low halogen requirements of <=1000ppm threshold. Antimony trioxide based flame retardants must also meet the <=1000ppm threshold requirement.

(3) MSL, Peak Temp. - The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.

(4) There may be additional marking, which relates to the logo, the lot trace code information, or the environmental category on the device.

(5) Multiple Device Markings will be inside parentheses. Only one Device Marking contained in parentheses and separated by a "~" will appear on a device. If a line is indented then it is a continuation of the previous line and the two combined represent the entire Device Marking for that device.



(6) Lead finish/Ball material - Orderable Devices may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead finish/Ball material values may wrap to two lines if the finish value exceeds the maximum column width.

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**OTHER QUALIFIED VERSIONS OF PCA9306 :**

- Automotive : [PCA9306-Q1](#)

NOTE: Qualified Version Definitions:

- Automotive - Q100 devices qualified for high-reliability automotive applications targeting zero defects

## TAPE AND REEL INFORMATION



### QUADRANT ASSIGNMENTS FOR PIN 1 ORIENTATION IN TAPE



\*All dimensions are nominal

Device	Package Type	Package Drawing	Pins	SPQ	Reel Diameter (mm)	Reel Width W1 (mm)	A0 (mm)	B0 (mm)	K0 (mm)	P1 (mm)	W (mm)	Pin1 Quadrant
PCA9306DCTR	SM8	DCT	8	3000	177.8	12.4	3.45	4.4	1.45	4.0	12.0	Q3
PCA9306DCTT	SM8	DCT	8	250	177.8	12.4	3.45	4.4	1.45	4.0	12.0	Q3
PCA9306DCUR	VSSOP	DCU	8	3000	178.0	9.0	2.25	3.35	1.05	4.0	8.0	Q3
PCA9306DCUT	VSSOP	DCU	8	250	178.0	9.0	2.25	3.35	1.05	4.0	8.0	Q3
PCA9306DQER	X2SON	DQE	8	5000	180.0	9.5	1.15	1.6	0.5	4.0	8.0	Q1
PCA9306DQER	X2SON	DQE	8	5000	180.0	8.4	1.2	1.6	0.55	4.0	8.0	Q1
PCA9306YZTR	DSBGA	YZT	8	3000	180.0	8.4	1.02	2.02	0.75	4.0	8.0	Q1

## TAPE AND REEL BOX DIMENSIONS



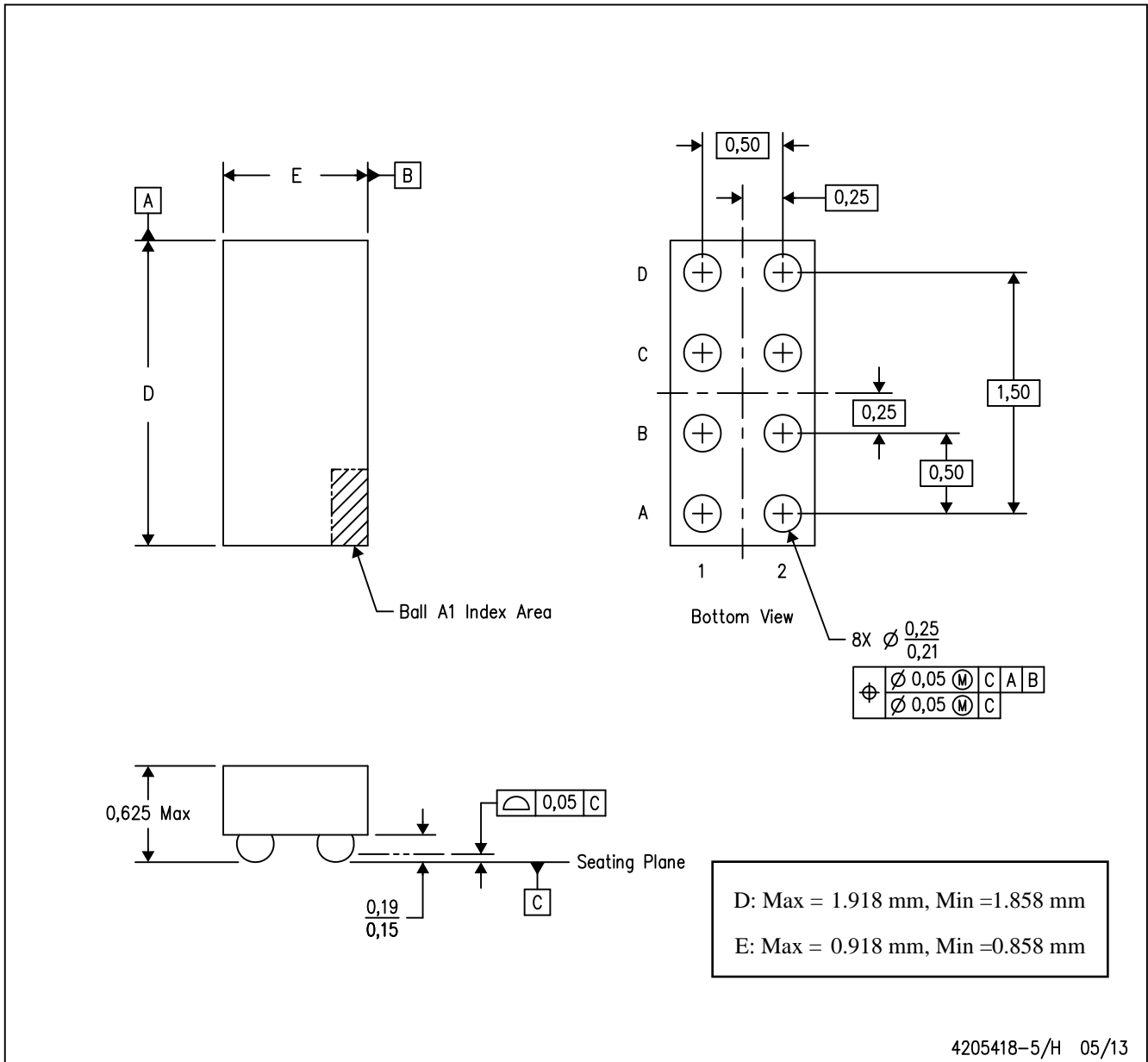
\*All dimensions are nominal

Device	Package Type	Package Drawing	Pins	SPQ	Length (mm)	Width (mm)	Height (mm)
PCA9306DCTR	SM8	DCT	8	3000	183.0	183.0	20.0
PCA9306DCTT	SM8	DCT	8	250	183.0	183.0	20.0
PCA9306DCUR	VSSOP	DCU	8	3000	180.0	180.0	18.0
PCA9306DCUT	VSSOP	DCU	8	250	180.0	180.0	18.0
PCA9306DQER	X2SON	DQE	8	5000	184.0	184.0	19.0
PCA9306DQER	X2SON	DQE	8	5000	202.0	201.0	28.0
PCA9306YZTR	DSBGA	YZT	8	3000	182.0	182.0	20.0

# MECHANICAL DATA

YZT (R-XBGA-N8)

DIE-SIZE BALL GRID ARRAY



- NOTES:
- A. All linear dimensions are in millimeters. Dimensioning and tolerancing per ASME Y14.5M-1994.
  - B. This drawing is subject to change without notice.
  - C. NanoFree™ package configuration.

NanoFree is a trademark of Texas Instruments.



4225266/A 09/2014

**NOTES:**

1. All linear dimensions are in millimeters. Any dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.
2. This drawing is subject to change without notice.
3. This dimension does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not exceed 0.15 mm per side.
4. Reference JEDEC registration MO-187 variation CA.

# EXAMPLE BOARD LAYOUT

DCU0008A

VSSOP - 0.9 mm max height

SMALL OUTLINE PACKAGE



LAND PATTERN EXAMPLE  
EXPOSED METAL SHOWN  
SCALE: 25X



4225266/A 09/2014

NOTES: (continued)

- 5. Publication IPC-7351 may have alternate designs.
- 6. Solder mask tolerances between and around signal pads can vary based on board fabrication site.

# EXAMPLE STENCIL DESIGN

DCU0008A

VSSOP - 0.9 mm max height

SMALL OUTLINE PACKAGE

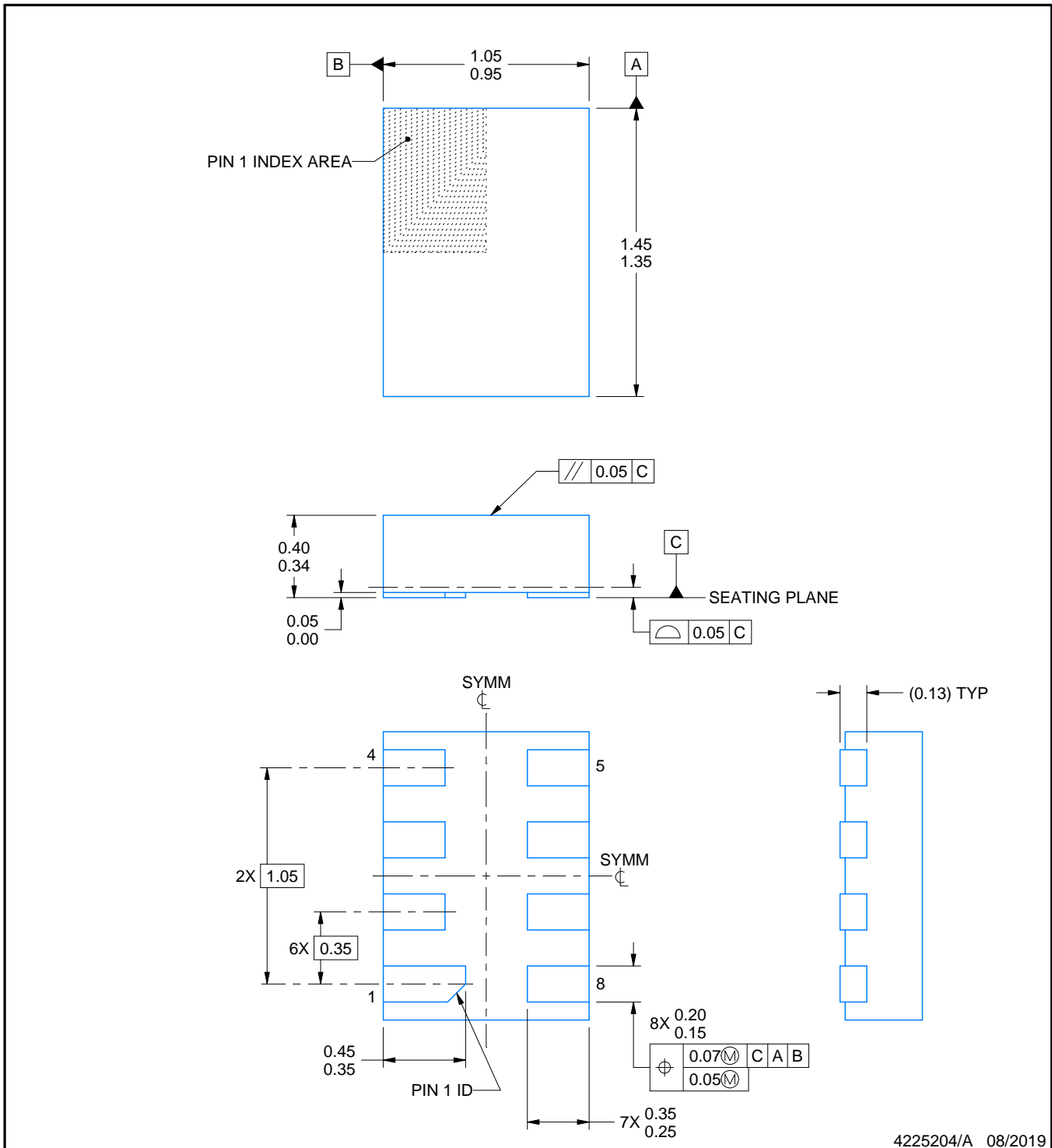


SOLDER PASTE EXAMPLE  
BASED ON 0.125 mm THICK STENCIL  
SCALE: 25X

4225266/A 09/2014

NOTES: (continued)

7. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.
8. Board assembly site may have different recommendations for stencil design.



4225204/A 08/2019

NOTES:

1. All linear dimensions are in millimeters. Any dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.
2. This drawing is subject to change without notice.
3. This package complies to JEDEC MO-287 variation X2EAF.



# EXAMPLE BOARD LAYOUT

DQE0008A

X2SON - 0.4 mm max height

PLASTIC SMALL OUTLINE - NO LEAD



LAND PATTERN EXAMPLE  
EXPOSED METAL SHOWN  
SCALE: 40X



SOLDER MASK DETAILS

4225204/A 08/2019

NOTES: (continued)

- This package is designed to be soldered to a thermal pad on the board. For more information, see Texas Instruments literature number SLUA271 ([www.ti.com/lit/slua271](http://www.ti.com/lit/slua271)).

# EXAMPLE STENCIL DESIGN

DQE0008A

X2SON - 0.4 mm max height

PLASTIC SMALL OUTLINE - NO LEAD

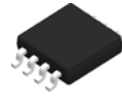


SOLDER PASTE EXAMPLE  
BASED ON 0.075 MM THICK STENCIL  
SCALE: 40X

4225204/A 08/2019

NOTES: (continued)

5. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.



4220784/C 06/2021

NOTES:

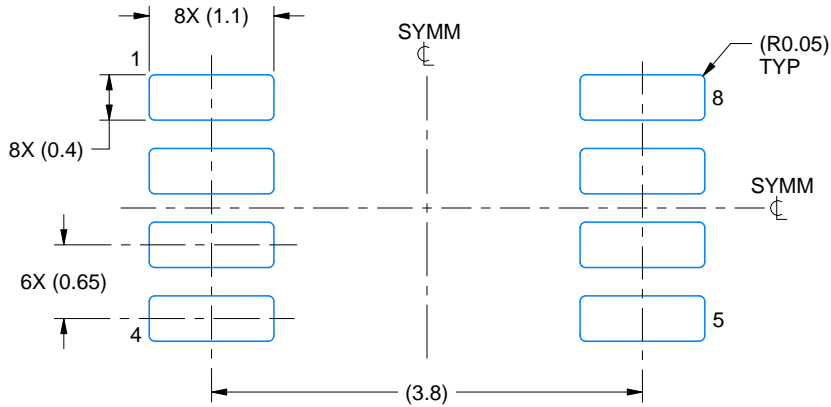
1. All linear dimensions are in millimeters. Dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.
2. This drawing is subject to change without notice.
3. This dimension does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not exceed 0.15 mm per side.
4. This dimension does not include interlead flash. Interlead flash shall not exceed 0.25 mm per side.

# EXAMPLE BOARD LAYOUT

DCT0008A

SSOP - 1.3 mm max height

SMALL OUTLINE PACKAGE



LAND PATTERN EXAMPLE  
EXPOSED METAL SHOWN  
SCALE:15X



SOLDER MASK DETAILS

4220784/C 06/2021

NOTES: (continued)

- 5. Publication IPC-7351 may have alternate designs.
- 6. Solder mask tolerances between and around signal pads can vary based on board fabrication site.

# EXAMPLE STENCIL DESIGN

DCT0008A

SSOP - 1.3 mm max height

SMALL OUTLINE PACKAGE



SOLDER PASTE EXAMPLE  
BASED ON 0.125 mm THICK STENCIL  
SCALE:15X

4220784/C 06/2021

NOTES: (continued)

7. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.
8. Board assembly site may have different recommendations for stencil design.

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